

FDP047N08

N-Channel PowerTrench[®] MOSFET 75V, 164A, 4.7m Ω

Features

- $R_{DS(on)} = 3.8 \text{m}\Omega$ (Typ.)@ $V_{GS} = 10 \text{V}$, $I_D = 80 \text{A}$
- · Fast switching speed
- · Low gate charge
- High performance trench technology for extremely low R_{DS(on)}
- · High power and current handling capability
- · RoHS compliant

Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

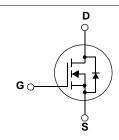
Application

• DC to DC convertors / Synchronous Rectification





TO-220 FDP Series



MOSFET Maximum Ratings T_C = 25°C unless otherwise noted*

GDS

Symbol		Parameter		Ratings	Units
V _{DSS}	Drain to Source Voltage			75	V
V _{GSS}	Gate to Source Voltage			±20	V
1	Drain Current	-Continuous (T _C = 25°C)		164*	A
ID	Drain Current	-Continuous (T _C = 100°C)		116*	А
I_{DM}	Drain Current - Pulsed (Note 1)		- Pulsed (Note 1)		А
E _{AS}	Single Pulsed Avalanche E	sed Avalanche Energy (Note 2)		670	mJ
dv/dt	Peak Diode Recovery dv/d	t	(Note 3)		V/ns
D	Davier Dissipation	$(T_C = 25^{\circ}C)$		268	W
P_{D}	Power Dissipation	- Derate above 25°C		1.79	W/°C
T _J , T _{STG}	Operating and Storage Ten	nperature Range		-55 to +175	°C
T _L	Maximum Lead Temperatu 1/8" from Case for 5 Secon	3 1 ,	3		°C

^{*}Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 80A.

Thermal Characteristics

Symbol	Parameter	Ratings	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.56	
$R_{\theta CS}$	Thermal Resistance, Case to Sink Typ.	0.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	62.5	

Package Marking and Ordering Information $T_C = 25$ °C unless otherwise noted

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP047N08	FDP047N08	TO-220	-	-	50

Electrical Characteristics

Symbol	Parameter	lest Conditions	win.	ıyp.	wax.	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A$, $V_{GS} = 0 V$, $T_C = 25 ^{\circ} C$	75	-	-	V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.02	-	V/°C
1	Zero Gate Voltage Drain Current	$V_{DS} = 75V, V_{GS} = 0V$	-	-	1	
DSS Zero Gate Voltage Drain Curre	Zero Gate Voltage Drain Current	$V_{DS} = 75V, T_{C} = 150^{\circ}C$	-	-	500	μΑ
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.5	3.5	4.5	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 80A$	-	3.7	4.7	mΩ
9 _{FS}	Forward Transconductance	$V_{DS} = 10V, I_{D} = 80A$ (Note	4) -	150	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 05V V 0V	-	7080	9415	pF
C _{oss}	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V$ f = 1MHz	-	870	1155	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1101112	-	410	615	pF

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			-	100	210	ns
t _r	Turn-On Rise Time	$V_{DD} = 37.5V, I_D = 80A$ $R_{GEN} = 25\Omega, V_{GS} = 10V$		-	147	304	ns
t _{d(off)}	Turn-Off Delay Time			-	220	450	ns
t _f	Turn-Off Fall Time		(Note 4, 5)	-	114	238	ns
Q _{g(tot)}	Total Gate Charge at 10V			-	117	152	nC
Q _{gs}	Gate to Source Gate Charge	$V_{DS} = 60V, I_{D} = 80A$		-	37	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	V _{GS} = 10V	(Note 4, 5)	-	32	-	nC

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current			-	164	Α
I_{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	656	Α
V_{SD}	Drain to Source Diode Forward Voltage V _{GS}	_S = 0V, I _{SD} = 80A	-	-	1.25	V
t _{rr}	Reverse Recovery Time V _{GS}	s = 0V, I _{SD} = 80A	-	45	-	ns
Q_{rr}	Reverse Recovery Charge dl _F /v	$dt = 100A/\mu s$ (Note 4)	-	66	-	nC

Notes

- Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 0.21mH, $\rm I_{AS}$ = 80A, $\rm V_{DD}$ = 50V, $\rm R_{G}$ = 25 Ω , Starting $\rm T_{J}$ = 25°C
- 3. $I_{SD} \le 75 A$, di/dt $\le 200 A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$
- 4. Pulse Test: Pulse width $\leq 300 \mu s, \, Duty \, Cycle \leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

FDP047N08 Rev. A www.fairchildsemi.com

Typical Performance Characteristics

Figure 1. On-Region Characteristics

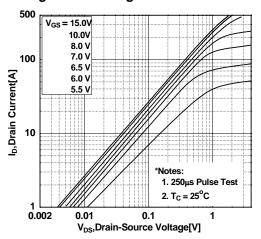


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

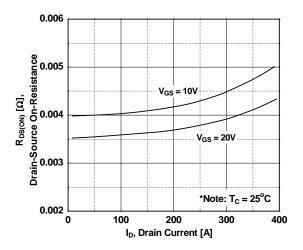


Figure 5. Capacitance Characteristics

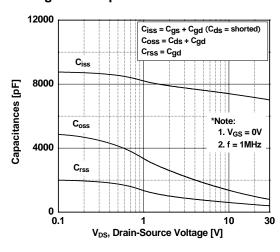


Figure 2. Transfer Characteristics

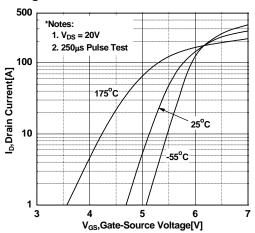


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

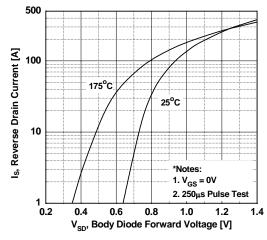
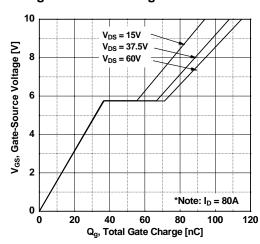


Figure 6. Gate Charge Characteristics



FDP047N08 Rev. A www.fairchildsemi.com

Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

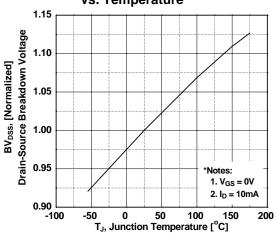


Figure 8. On-Resistance Variation vs. Temperature

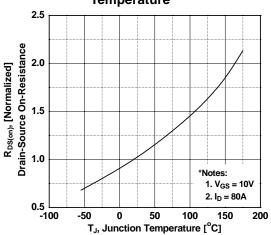


Figure 9. Maximum Safe Operating Area

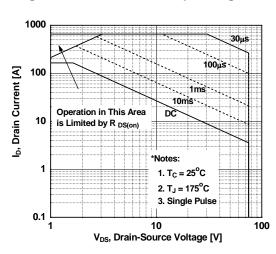


Figure 10. Maximum Drain Current vs. Case Temperature

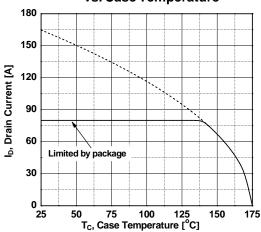
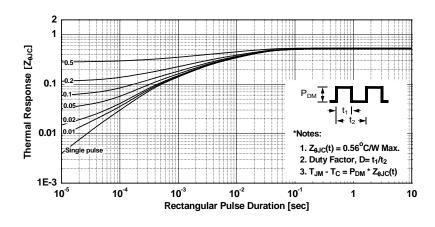
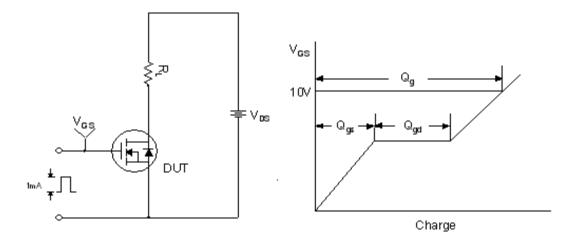


Figure 11. Transient Thermal Response Curve

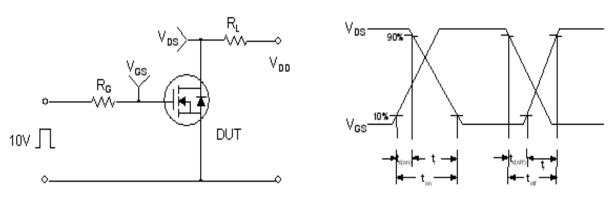


FDP047N08 Rev. A www.fairchildsemi.com

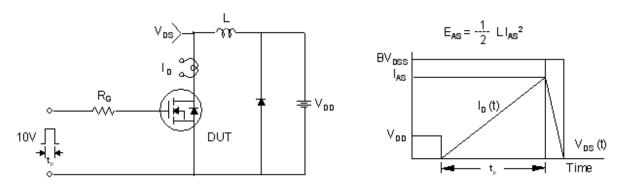
Gate Charge Test Circuit & Waveform



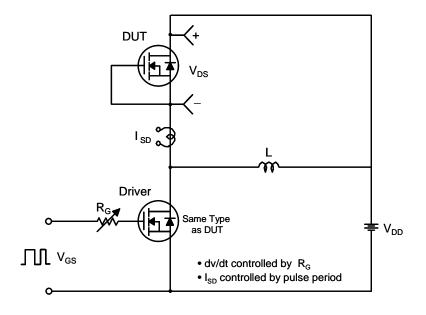
Resistive Switching Test Circuit & Waveforms

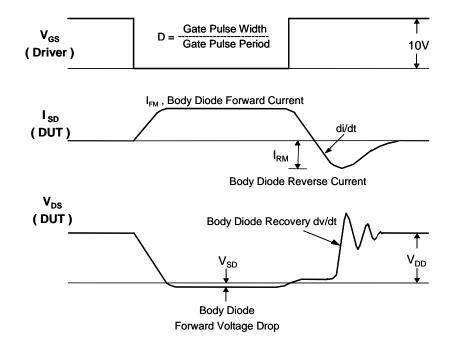


Unclamped Inductive Switching Test Circuit & Waveforms



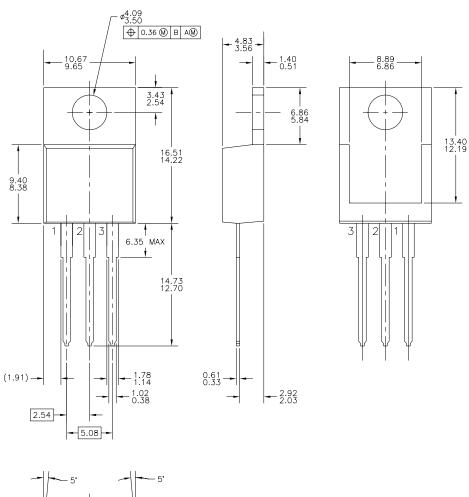
Peak Diode Recovery dv/dt Test Circuit & Waveforms

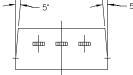




Mechanical Dimensions

TO-220









TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidianries, and is not intended to be an exhaustive list of all such trademarks.

FPS™ PDP-SPM™ SupreMOS™ FRFET® Power220® Build it Now™ SyncFET™ CorePLUS™ Global Power ResourceSM POWEREDGE® SYSTEM ® CROSSVOLT™ Green FPS™ Power-SPM™ The Power Franchise® CTL™ Green FPS™ e-Series™ PowerTrench® p wer GTO™ Current Transfer Logic™ Programmable Active Droop™ i-Lo™ $\mathsf{EcoSPARK}^{\texttt{®}}$ QFET® TinyBoost™ EZSWITCH™ * QSTM IntelliMAX™ TinyBuck™ ISOPLANAR™ QT Optoelectronics™ $\mathsf{TinyLogic}^{\mathbb{R}}$ MegaBuck™ Quiet Series™ TINYOPTO™ MICROCOUPLER™ RapidConfigure™ TinyPower™ Fairchild® SMART START™ MicroFET™ TinyPWM™ Fairchild Semiconductor® MicroPak™ SPM[®] TinyWire™ FACT Quiet Series™ MillerDrive™ STEALTH™ µSerDes™ FACT[®] Motion-SPM™ SuperFET™ UHC® $\mathsf{FAST}^{\mathbb{B}}$ OPTOLOGIC® SuperSOT™-3 Ultra FRFET™ OPTOPLANAR® FastvCore[™] SuperSOT™-6 UniFET™ FlashWriter® * SuperSOT™-8 VCX^{TM}

* EZSWITCHTM and FlashWriter® are trademarks of System General Corporation, used under license by Fairchild Semiconductor.

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

- Life support devices or systems are devices or systems which,

 (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support, device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information Formative or In Design		This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary First Production		This datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed Full Production		This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
Obsolete Not In Production		This datasheet contains specifications on a product that has been discontinued by Fairchild Semiconductor. The datasheet is printed for reference information only.

Rev. I33